

Optical properties of MoSe₂ grown on various substrates using MBE

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We report on the growth details and characterization of thin MoSe₂ layers. Growth has been realized in molecular beam epitaxy (MBE) chamber optimized for II-VI semiconductor compounds, equipped with standard effusion cell working as a source of selenium, and e-beam evaporator, working as a source of molybdenum. Deposition rate of Mo (0.5-25 nm/h), which governs also the growth rate of MoSe₂, was calibrated by deposition of thin metal layers on glass and subsequent study with XPS, AFM and optical transmission.

Using various substrates: GaAs, SiO₂, Mo, BN, and graphene, we have found wide range of growth conditions enabling deposition of 1-3 monolayer thick MoSe₂ exhibiting characteristic Raman line close to 240 cm⁻¹. We found that excitonic photoluminescence (PL) (measured mostly at room temperature) is much more sensitive to MoSe₂ growth conditions than Raman scattering. In particular, only well-defined amount of MoSe₂ leads to observable PL peak. The best optical properties: sharp Raman lines, reasonably strong excitonic PL, and several excitonic peaks in reflectivity spectrum (Fig. 1), were obtained for MoSe₂ layers grown on two kinds of substrates: amorphous SiO₂ and graphene.

Optical properties of MBE grown MoSe₂ still cannot compete with those of mechanically exfoliated MoSe₂ in terms of e.g. PL intensity. There is however a great advantage of the MBE samples which is their homogeneity. We have found that the optical properties of MBE MoSe₂ do not change significantly over large distances on the substrates. We believe that further optimization of the growth conditions will result in large area layers of technological relevance.

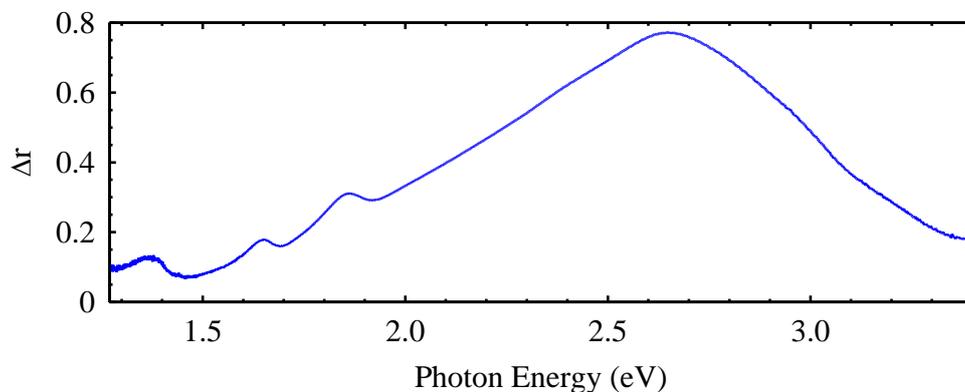


Fig. 1. Low temperature ($T = 7$ K) differential reflection of MoSe₂ grown on SiO₂ buffer, on Si substrate. Series of excitonic peaks is well visible, in agreement with literature data for MoSe₂ grown using other methods [1].